Se	earch	n Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,665	LEE ET AL.	
Examiner	Art Unit	
Tung X. Le	2821	

SEARCHED			
Class	Subclass	Date	Examiner
343	867	11/1/2005	TXL
118	723	11/1/2005	TXL
315	111.51 111	11/1/2005	TXL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	)
	DATE	EXMR
EAST see search history print out	11/1/2005	TXL
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